

Fixed capacitors for use in electronic equipment
Part 8: Sectional specification: Fixed capacitors of
ceramic dielectric, Class 1

EESTI STANDARDI EESSÕNA

NATIONAL FOREWORD

See Eesti standard EVS-EN 60384-8:2015 sisaldab Euroopa standardi EN 60384-8:2015 ingliskeelset teksti.	This Estonian standard EVS-EN 60384-8:2015 consists of the English text of the European standard EN 60384-8:2015.
Standard on jõustunud sellekohase teate avaldamisega EVS Teatajas	This standard has been endorsed with a notification published in the official bulletin of the Estonian Centre for Standardisation.
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English Version

Fixed capacitors for use in electronic equipment - Part 8:
Sectional specification: Fixed capacitors of ceramic dielectric,
Class 1
(IEC 60384-8:2015)

Condensateurs fixes utilisés dans les équipements
électroniques - Partie 8: Spécification intermédiaire:
Condensateurs fixes à diélectrique en céramique, Classe 1
(IEC 60384-8:2015)

Festkondensatoren zur Verwendung in Geräten der
Elektronik - Teil 8: Rahmenspezifikation - Keramik-
Festkondensatoren, Klasse 1
(IEC 60384-8:2015)

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European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

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Foreword

The text of document 40/2338/FDIS, future edition 4 of IEC 60384-8, prepared by IEC TC 40, "Capacitors and resistors for electronic equipment" was submitted to the IEC-CENELEC parallel vote and was approved by CENELEC as EN 60384-8:2015.

The following dates are fixed:

- latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2016-01-14
- latest date by which the national standards conflicting with the document have to be withdrawn (dow) 2018-04-14

This document supersedes EN 60384-8:2005.

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Endorsement notice

The text of the International Standard IEC 60384-8:2015 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following notes have to be added for the standards indicated:

IEC 60384-14	NOTE	Harmonized as EN 60384-14.
IEC 60384-21	NOTE	Harmonized as EN 60384-21.

Annex ZA (normative)

Normative references to international publications with their corresponding European publications

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 When an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: www.cenelec.eu.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 60063	1963	Preferred number series for resistors and capacitors	-	-
+A1	1967		-	-
+A2	1977		-	-
IEC 60068-1	2013	Environmental testing -- Part 1: General and guidance	EN 60068-1	2014
IEC 60384-1	2008	Fixed capacitors for use in electronic equipment -- Part 1: Generic specification	EN 60384-1	2009
IEC 61193-2	2007	Quality assessment systems -- Part 2: Selection and use of sampling plans for inspection of electronic components and packages	EN 61193-2	2007
ISO 3	1973	Preferred numbers; Series of preferred numbers	-	-

CONTENTS

FOREWORD.....	6
1 General.....	8
1.1 Scope.....	8
1.2 Object.....	8
1.3 Normative references.....	8
1.4 Information to be given in a detail specification.....	8
1.4.1 General.....	8
1.4.2 Outline drawing and dimensions.....	9
1.4.3 Mounting.....	9
1.4.4 Ratings and characteristics.....	9
1.4.5 Marking.....	10
1.5 Terms and definitions.....	10
1.6 Marking.....	10
1.6.1 General.....	10
1.6.2 Marking for code of temperature coefficient.....	11
1.6.3 Marking on the body.....	11
1.6.4 Marking of the packaging.....	11
1.6.5 Additional marking.....	11
2 Preferred ratings and characteristics.....	11
2.1 Preferred characteristics.....	11
2.2 Preferred values of ratings.....	11
2.2.1 Rated temperature.....	11
2.2.2 Rated voltage (U_R).....	12
2.2.3 Category voltage (U_C).....	12
2.2.4 Preferred values of nominal capacitance and associated tolerance values.....	12
2.2.5 Temperature coefficient (α).....	12
3 Quality assessment procedures.....	16
3.1 Primary stage of manufacture.....	16
3.2 Structurally similar components.....	16
3.3 Certified test records of released lots.....	16
3.4 Qualification approval.....	16
3.4.1 General.....	16
3.4.2 Qualification approval on the basis of the fixed sample size procedure.....	16
3.4.3 Tests.....	17
3.5 Quality conformance inspection.....	22
3.5.1 Formation of inspection lots.....	22
3.5.2 Test schedule.....	23
3.5.3 Delayed delivery.....	23
3.5.4 Assessment levels.....	23
4 Test and measurement procedures.....	24
4.1 General.....	24
4.2 Visual examination and check of dimensions.....	24
4.3 Electrical tests.....	24
4.3.1 Capacitance.....	24
4.3.2 Tangent of loss angle ($\tan \delta$).....	25

4.3.3	Insulation resistance (R_i)	25
4.3.4	Voltage proof	26
4.4	Temperature coefficient (α) and temperature cyclic drift of capacitance	27
4.4.1	General	27
4.4.2	Preliminary drying	27
4.4.3	Measuring conditions	27
4.4.4	Requirements	27
4.5	Robustness of terminations	27
4.6	Resistance to soldering heat	27
4.6.1	General	27
4.6.2	Initial measurement	27
4.6.3	Test conditions	27
4.6.4	Final inspection, measurements and requirements	27
4.7	Solderability	28
4.7.1	General	28
4.7.2	Test conditions	28
4.7.3	Final inspection, measurements and requirements	28
4.8	Rapid change of temperature (if required)	28
4.8.1	General	28
4.8.2	Initial measurement	28
4.8.3	Test conditions	28
4.8.4	Recovery	28
4.9	Vibration	28
4.9.1	General	28
4.9.2	Test conditions	29
4.9.3	Final inspection, measurements and requirements	29
4.10	Bump (repetitive shock)	29
4.10.1	General	29
4.10.2	Initial measurements	29
4.10.3	Test conditions	29
4.10.4	Final inspection, measurements and requirements	29
4.11	Shock (non-repetitive shock)	29
4.11.1	General	29
4.11.2	Initial measurements	30
4.11.3	Test conditions	30
4.11.4	Final inspection, measurements and requirements	30
4.12	Climatic sequence	30
4.12.1	General	30
4.12.2	Initial measurements	30
4.12.3	Dry heat	30
4.12.4	Damp heat, cyclic, Test Db, first cycle	31
4.12.5	Cold	31
4.12.6	Low air pressure	31
4.12.7	Damp heat, cyclic, Test Db, remaining cycles	31
4.13	Damp heat, steady state	32
4.13.1	General	32
4.13.2	Initial measurement	32
4.13.3	Test conditions	32
4.13.4	Recovery	33

4.13.5	Final inspection, measurements and requirements.....	33
4.14	Endurance	33
4.14.1	General	33
4.14.2	Initial measurement	33
4.14.3	Test conditions	33
4.14.4	Recovery	34
4.14.5	Final inspection, measurements and requirements.....	34
4.15	Component solvent resistance (if required)	34
4.16	Solvent resistance of the marking (if required)	34
Annex A (normative) Figures with limits of variation of capacitance with temperature for certain temperature coefficients and classes.....		35
Bibliography.....		43
Figure A.1	– α : +100 ($10^{-6}/K$).....	35
Figure A.2	– α : 0 ($10^{-6}/K$)	36
Figure A.3	– α : –33 ($10^{-6}/K$).....	36
Figure A.4	– α : –75 ($10^{-6}/K$).....	37
Figure A.5	– α : –150 ($10^{-6}/K$).....	37
Figure A.6	– α : –220 ($10^{-6}/K$).....	38
Figure A.7	– α : –330 ($10^{-6}/K$).....	38
Figure A.8	– α : –470 ($10^{-6}/K$).....	39
Figure A.9	– α : –750 ($10^{-6}/K$).....	39
Figure A.10	– α : –1 000 ($10^{-6}/K$).....	40
Figure A.11	– α : –1 500 ($10^{-6}/K$).....	40
Figure A.12	– α : –2 200 ($10^{-6}/K$).....	41
Figure A.13	– α : –3 300 ($10^{-6}/K$).....	41
Figure A.14	– α : –4 700 ($10^{-6}/K$).....	42
Figure A.15	– α : –5 600 ($10^{-6}/K$).....	42
Table 1	– Preferred tolerances on nominal capacitance	12
Table 2	– Nominal temperature coefficient and tolerances	13
Table 3	– Combination of temperature coefficient and tolerance	14
Table 4	– Sampling plan together with numbers of permissible non-conforming items for qualification approval tests, assessment level EZ	18
Table 5	– Test schedule for qualification approval.....	19
Table 6	– Lot-by-lot inspection	23
Table 7	– Periodic tests	24
Table 8	– Tangent of loss angle	25
Table 9	– Insulation resistance requirements	26
Table 10	– Test voltages for single layer ceramic capacitors.....	26
Table 11	– Test voltages for leaded multilayer ceramic capacitors	26
Table 12	– Temperature cyclic drift limits	27
Table 13	– Requirements	28
Table 14	– Preferred severities (of non-repetitive shock)	30

Table 15 – Maximum capacitance change.....	30
Table 16 – Number of damp heat cycles	31
Table 17 – Final inspection, measurements and requirements	32
Table 18 – Test conditions for damp heat, steady state.....	32
Table 19 – Final inspection, measurements and requirements	33
Table 20 – Endurance test conditions	34
Table 21 – Final inspection, measurements and requirements	34

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